Power MOSFET

-20 V, -4.9 A, P-Channel ChipFET™

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package Saves Board Space
- Pb–Free Package is Available

Applications

• Power Management in Portable and Battery–Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

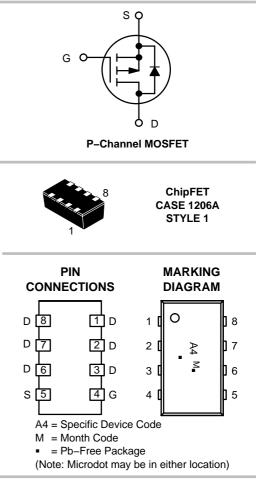
MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
–20 V	56 mΩ @ -4.5	-4.9 A



ORDERING INFORMATION

Device	Package	Shipping [†]
NTHS5443T1	ChipFET	3000/Tape & Reel
NTHS5443T1G	ChipFET (Pb–Free)	3000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

V _{DS} V _{GS} I _D		20 12	V V
	±	12	V
I _D			
	-4.9 -3.5	-3.6 -2.6	A
I _{DM}	±	15	А
۱ _S	-4.9	-3.6	А
PD	2.5 1.3	1.3 0.7	W
T _J , T _{stg}	–55 to	9 +150	°C
r	I _{DM} Is P _D T _J , T _{stg}	$\begin{array}{c} -4.9 \\ -3.5 \\ \hline I_{DM} & \pm \\ \hline I_S & -4.9 \\ \hline P_D & 2.5 \\ 1.3 \\ \hline T_J, T_{stg} & -55 tc \end{array}$	$\begin{array}{c c} -4.9 \\ -3.5 \\ \hline \\ I_{DM} \\ 1_{S} \\ I_{S} \\ P_{D} \\ 2.5 \\ 1.3 \\ 0.7 \\ \hline \end{array} \begin{array}{c} -3.6 \\$

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).

THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
Maximum Junction-to-Ambient (Note 2) t \leq 5 s Steady State	R _{θJA}	40 80	50 95	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R_{\thetaJF}	15	20	°C/W

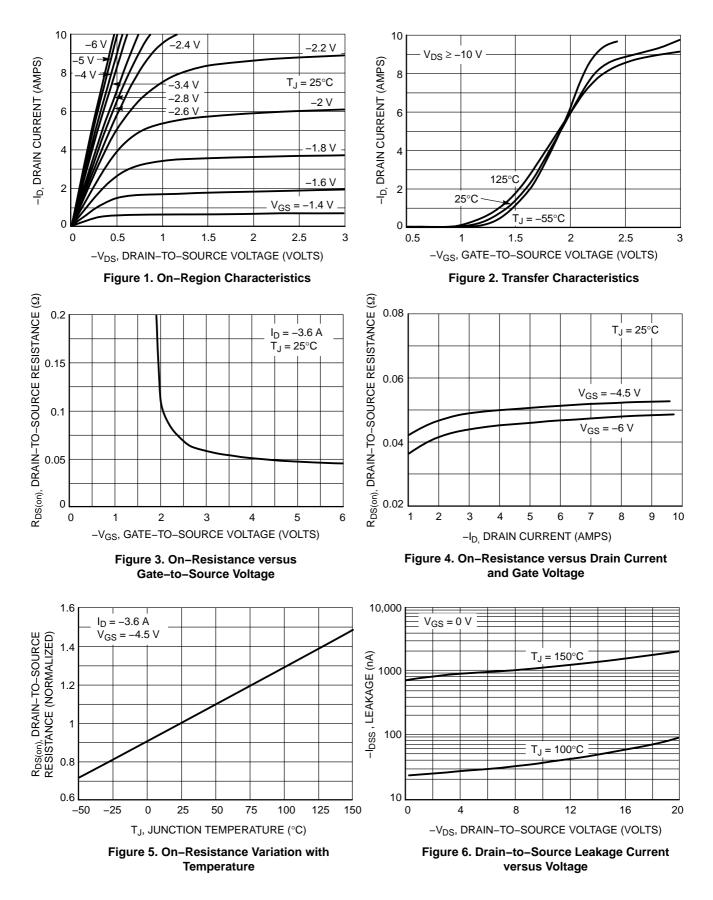
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

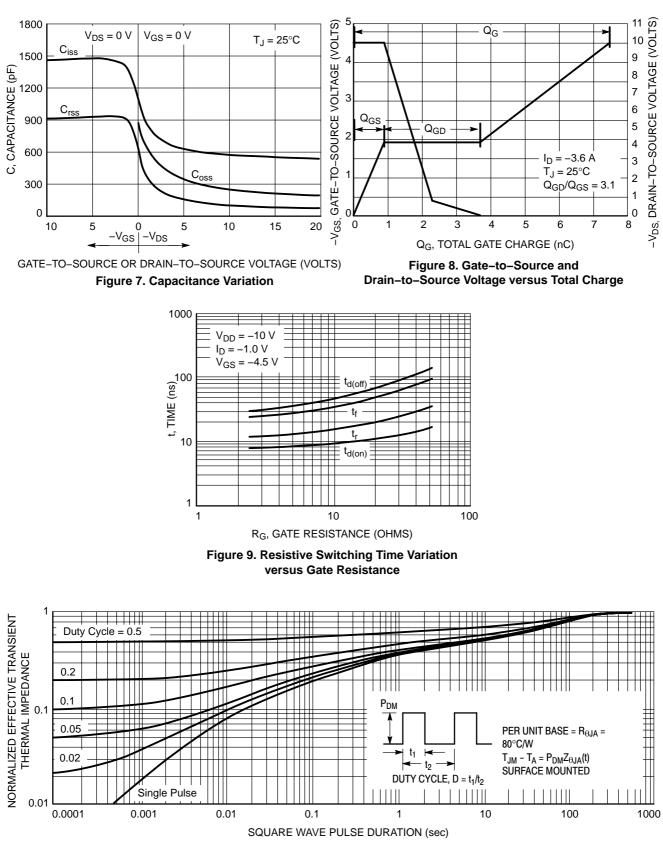
Characteristic	Symbol	ymbol Test Condition		Тур	Мах	Unit	
Static							
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-0.6			V	
Gate-Body Leakage	I _{GSS}	V_{DS} = 0 V, V_{GS} = \pm 12 V			±100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -16 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-1.0	μΑ	
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 85^{\circ}\text{C}$			-5.0		
On-State Drain Current (Note 3)	I _{D(on)}	V_{DS} \leq –5.0 V, V_{GS} = –4.5 V	–15			А	
Drain–Source On–State Resistance (Note 3)	r _{DS(on)}	V_{GS} = -4.5 V, I_{D} = -3.6 A V_{GS} = -3.6 V, I_{D} = -3.3 A		0.056 0.065	0.065 0.074	Ω	
		V_{GS} = -2.5 V, I _D = -2.7 A		0.095	0.110	1	
Forward Transconductance (Note 3)	9 _{fs}	V _{DS} = -10 V, I _D = -3.6 A		10		S	
Diode Forward Voltage (Note 3)	V _{SD}	$I_{S} = -1.1 \text{ A}, V_{GS} = 0 \text{ V}$		-0.8	-1.2	V	
Dynamic (Note 4)	-	<u>.</u>	•	-	-	-	
Total Gate Charge	Q _G			7.5	12	nC	
		$V_{} = -10 V V_{} = -15 V$		1	1	-	

Total Gate Charge	Q _G		7.5	12	nC
Gate-Source Charge	Q _{GS}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V},$ $I_{D} = -3.6 \text{ A}$	0.9	2.8	1
Gate-Drain Charge	Q _{GD}		2.2	-	
Turn-On Delay Time	t _{d(on)}		8.5	13	ns
Rise Time	tr	$V_{DD} = -10 \text{ V}, \text{ R}_{\text{L}} = 10 \Omega$ $I_{\text{D}} \cong -1.0 \text{ A}, \text{ V}_{\text{GEN}} = -4.5 \text{ V},$	14	21	
Turn-Off Delay Time	t _{d(off)}	$R_{\rm G} = 6 \ \Omega$	38	57	
Fall Time	t _f	1	30	45	1
Source–Drain Reverse Recovery Time	t _{rr}	I _F = -1.1 A, di/dt = 100 A/μs	30	60	ns

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS



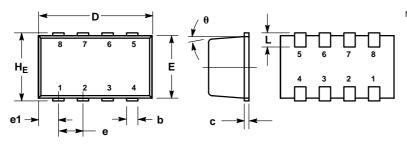


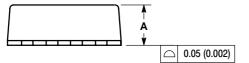
TYPICAL ELECTRICAL CHARACTERISTICS



PACKAGE DIMENSIONS

ChipFET™ CASE 1206A-03 ISSUE G





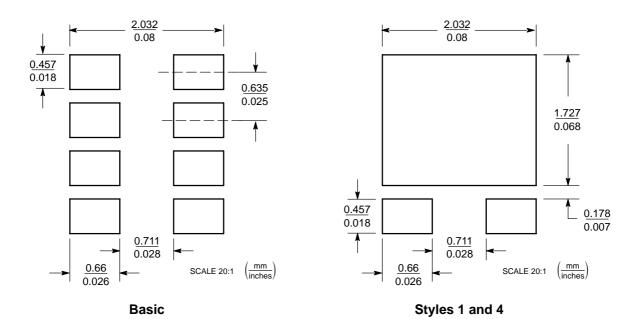
- NOTES:
 DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
 MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
 LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
 DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
 NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.00	1.05	1.10	0.039	0.041	0.043	
q	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.025 BSC			
e1	0.55 BSC			0.022 BSC			
L	0.28	0.35	0.42	0.011	0.014	0.017	
HE	1.80	1.90	2.00	0.071	0.075	0.079	
θ	5° NOM			5° NOM			

- STYLE 1: PIN 1. DRAIN 2. DRAIN 4. GATE 5. SOURCE 6. DRAIN 7. DRAIN 8 DRAIN

 - 8. DRAIN





*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ChipFET is a trademark of Vishay Siliconix.

ON Semiconductor and are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use payes that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunit//Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 61312, Phoenix, Arizona 85082–1312 USA Phone: 480–829–7710 or 800–344–3860 Toll Free USA/Canada Fax: 480–829–7709 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800–282–9855 Toll Free USA/Canada

Japan: ON Semiconductor, Japan Customer Focus Center 2–9–1 Kamimeguro, Meguro–ku, Tokyo, Japan 153–0051 Phone: 81–3–5773–3850 ON Semiconductor Website: http://onsemi.com

Order Literature: http://www.onsemi.com/litorder

For additional information, please contact your local Sales Representative.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

ON Semiconductor: <u>NTHS5443T1G</u>